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650 V

1.2 V

170 mΩ

7 A

D

S

Normally – OFF Silicon Carbide Super Junction Transistor

Features

- 250 °C maximum operating temperature
- Temperature independent switching performance
- Electrically isolated base-plate
- Gate oxide free SiC switch
- Suitable for connecting an anti-parallel diode
- Positive temperature coefficient for easy paralleling
- · Low gate charge
- · Low intrinsic capacitance

Advantages

- Low switching losses
- Higher efficiency
- High temperature operation
- · High short circuit withstand capability

Package

RoHS Compliant



TO - 257 (Isolated Base-plate Hermetic Package)

VDS

ID

V_{DS(ON)}

R_{DS(ON)}

Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

Maximum Ratings at T_i = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Drain – Source Voltage	V _{DS}	$V_{GS} = 0 V$	650	V
Continuous Drain Current	I _D	T _C = 158 °C	7	А
Gate Peak Current	I _{GM}		5	А
Reverse Gate – Source Voltage	V _{GS}		200	V
Reverse Drain – Source Voltage	V _{DS}		40	V
Power Dissipation	P _{tot}	T _C = 25 °C	8	W
Operating and Storage Temperature	T _j , T _{stg}		-55 to 250	°C

Electrical Characteristics at T_j = 250 °C, unless otherwise specified

Deveryorken	Quarte al	Conditions	Values		11	
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
On Characteristics						
		I _D = 7 A, I _G = 250 mA, T _j = 25 °C		1.2		
Drain – Source On Voltage	$V_{DS(ON)}$	I _D = 7 A, I _G = 500 mA, T _j = 175 °C		2.2		V
		I _D = 7 A, I _G = 500 mA, T _j = 250 °C		3.1		
		I _D = 7 A, I _G = 250 mA, T _j = 25 °C		170		
Drain – Source On Resistance	R _{DS(ON)}	I _D = 7 A, I _G = 500 mA, T _j = 175 °C		330		mΩ
		I _D = 7 A, I _G = 500 mA, T _j = 250 °C		550		
Gate Forward Voltage	$V_{GS(FWD)}$	I _G = 500 mA, T _j = 25 °C		3	V	
		$I_{G} = 500 \text{ mA}, T_{j} = 250 \text{ °C}$		2.7		V
DC Current Coin	0	V _{DS} = 5 V, I _D = 10 A, T _j = 25 °C		120		
DC Current Gain	β	V _{DS} = 5 V, I _D = 10 A, T _i = 250 °C		80		

Off Characteristics

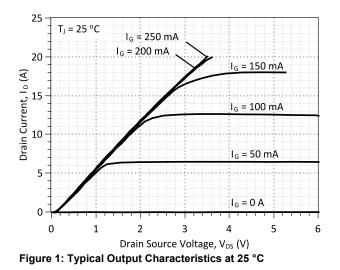
		V _R = 650 V, V _{GS} = 0 V, T _j = 25 °C	2.5	
Drain Leakage Current	I _{DSS}	V _R = 650 V, V _{GS} = 0 V, T _j = 175 °C	4	μΑ
		V_R = 650 V, V_{GS} = 0 V, T_j = 250 °C	10	



Electrical Characteristics at T_i = 250 °C, unless otherwise specified

Parameter	Symphol	Symbol Conditions	Values		11	
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
Dynamic Characteristics						
Input Capacitance	C _{iss}			720		pF
Output Capacitance	C _{oss}	V _{DS} = 35 V, V _{GS} = 0 V, f = 1 MHz, T _{vi} = 25 °C		88		pF
Reverse Transfer Capacitance	C _{rss}	$1 - 1 \text{ Will} 2, 1_{\text{VJ}} - 23 \text{ C}$		88		pF
Switching Characteristics						
Turn On Delay Time	t _{d(on)}			11		ns
Rise Time	tr	$V_{DD} = 400 \text{ V}, I_D = 10 \text{ A},$		28		ns
Turn Off Delay Time	t _{d(off)}	$R_{G(on)} = R_{G(off)} = 32 \Omega,$		76		ns
Fall Time	t _f	V _{GS} = -8/15 V ,T _i = 175 °C		38		ns
Turn-On Energy Per Pulse	Eon	Refer to Figure 10 for gate drive current waveforms		34		μJ
Turn-Off Energy Per Pulse	E _{off}			64		μJ
Total Switching Energy	E _{ts}			98		μJ
Turn On Delay Time	t _{d(on)}			12		ns
Rise Time	t _r	$V_{DD} = 400 \text{ V}, I_D = 10 \text{ A},$		30		ns
Turn Off Delay Time	t _{d(off)}	$\begin{array}{c} R_{G(on)} = R_{G(off)} = 32\ \Omega, \\ V_{GS} = -8/15\ V, T_{j} = 250\ ^{\circ}C \\ Refer to Figure 10 for gate drive \\ current waveforms \end{array}$		73		ns
Fall Time	t _f			58		ns
Turn-On Energy Per Pulse	Eon			43		μJ
Turn-Off Energy Per Pulse	E _{off}			82		μJ
Total Switching Energy	E _{ts}]		125		μJ

Thermal resistance, junction - case	R _{thJC}	2.5	°C/W



25 T_J = 175 °C I_G = 500 mA 20 I_G = 400 mA I_G = 300 mA Drain Current, I_D (A) I_G = 200 mA l_G = 100 mA 5 $I_G = 0 A$ 0 0 5 10 15 Drain Source Voltage, V_{DS} (V) Figure 2: Typical Output Characteristics at 175 °C



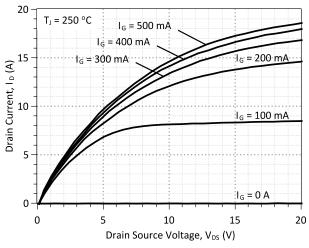


Figure 3: Typical Output Characteristics at 250 °C

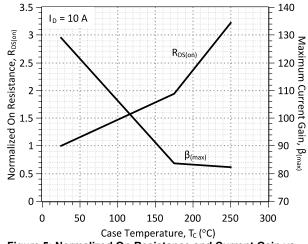


Figure 5: Normalized On-Resistance and Current Gain vs. Temperature

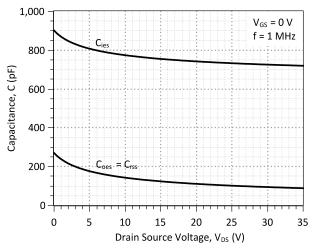


Figure 7: Typical Capacitance vs Drain-Source Voltage

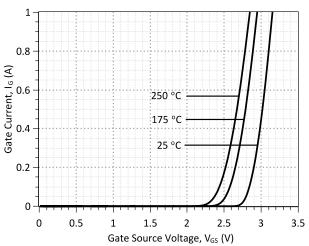


Figure 4: Typical Gate Source I-V Characteristics vs. Temperature

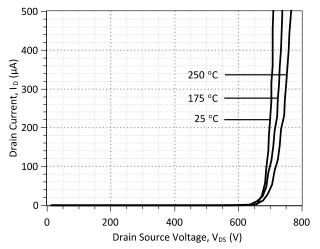
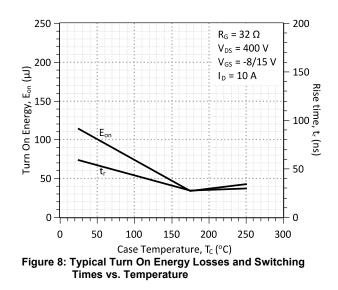
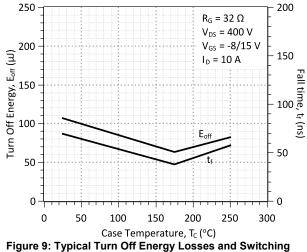
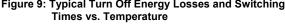


Figure 6: Typical Blocking Characteristics









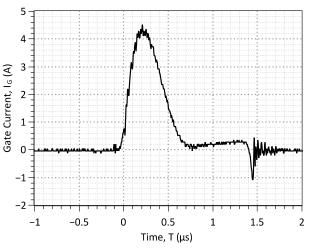
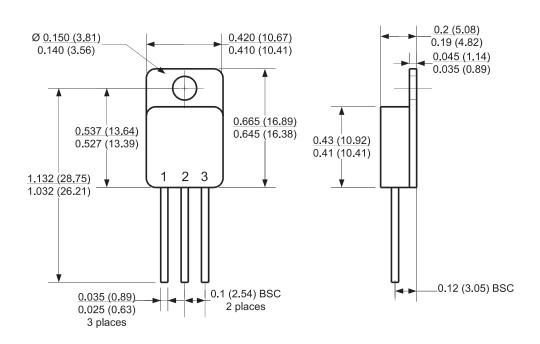


Figure 10: Typical Gate Current Waveform

Package Dimensions:



PACKAGE OUTLINE



NOTE

CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS



Revision History					
Date	Revision	Comments	Supersedes		
2012/08/24	0	Initial release			

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